Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/826,459	ALDRICH ET AL.	
Examiner	Art Unit	
Tan V. Mai	2193	

	SEARCHED				
Class	Subclass	Date	Examiner		
708	319, 523- 524	4/25/2007	MAI		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	4/25/2007	MAI		
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